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** CONTINUING DATA *****

PIK none

** FOREIGN APPLICATIONS *****

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PIK OK

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

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35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	COUNTRY	DRAWING	CLAIMS	CLAIMS
Verified and Acknowledged <i>[Signature]</i> <i>PIK</i> Examiner's Signature Initials	KOREA, REPUBLIC OF	6	5	1

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TITLE

Method for measuring particles in glass substrate